

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/652,458 VYSSOTSKI ET AL.	
		Examiner Erin L. Dogan	Art Unit 2115	Page 1 of 1

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*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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